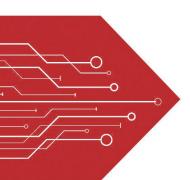
MSKSEMI















ESD

TVS

TSS

MOV

GDT

PLED

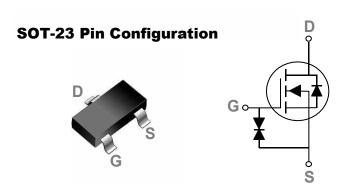
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www.msksemi.com









BVDSS	RDSON	ID
60V	2.2Ω	0.3A

Features

- 60V,0.3A, RDS(ON) =2.2Ω@VGS=10V
- Improved dv/dt capability
- Fast switching
- Green Device Available
- G-S ESD Protection Diode Embedded
- ESD protected up to 2KV

Applications

- Motor Drive
- Power Tools
- LED Lighting

Absolute Maximum Ratings Tc=25℃ unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	60	V
V _{GS}	Gate-Sou₁ce Voltage	±20	V
1.	Drain Current – Continuous (T _C =25℃)	0.3	А
Drain Current – Continuous (Tc=100°c)		0.1	А
I _{DM}	Drain Current – Pulsed ¹	0.8	А
<u> </u>	Power Dissipation (T _C =25℃)	0.35	W
o _D	Power Dissipation – Derate above 25℃	0.003	W/∘c
Γ _{STG}	Storage Temperature Range	-50 to 150	°C
T _J	Operating Junction Temperature Range	-50 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		357	°C/W



Electrical Characteristics (T_J=25 ℃, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	60			V
L	Drain Source Lookege Current	V _{DS} =60V , V _{GS} =0V , T _J =25℃			1	uA
IDSS	Drain-Source Leakage Current	V _{DS} =48V , V _{GS} =0V , T _J =125℃			10	uA
I _{GSS}	Gate-Source Leakage Current	V _{GS} -±20V , V _{DS} =0V			±10	uA

On Characteristics

R _{DS(ON)}	R _{DS(ON)} Static Drain-Source On-Resistance	V _{GS} =10V , I _D =0.3A	-	2.2	2.8	Ω
RDS(ON) Static Drain-Source On-Resistance	V _{GS} =4.5V , I _D =0.2A	-	2.4	3.0	Ω	
$V_{GS(th)}$	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	1	1.6	2.5	٧
gfs	Forward Transconductance	V _{DS} =10V , I _D =0.3A		0.5		S

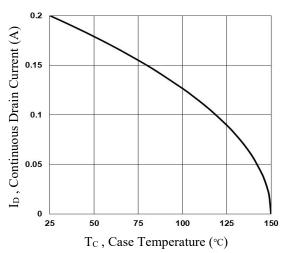
Dynamic and switching Characteristics

Qg	Total Gate Charge ^{2, 3}			3.7	5.6	
Q_{gs}	Gate-Source Charge ^{2,3}	V_{DS} =30V , V_{GS} =10V , I_{D} =1A	-	0.9	1.4	nC
Q_{gd}	Gate-Drain Charge ^{2, 3}		1	0.4	0.6	
T _{d(on)}	Turn-On Delay Time ^{2, 3}		1	3	6	
Tr	Rise Time ^{2,3}	V_{DD} =30V , V_{GS} =10V , R_{G} =6 Ω	1	5	10	ns
$T_{d(off)}$	Turn-Off Delay Time ^{2, 3}	I _D =0.2A		14	27	115
T _f	Fall Time ^{2, 3}			9	17	
C _{iss}	Input Capacitance		1	25.5	38	
Coss	Output Capacitance	V_{DS} =30V , V_{GS} =0V , F=1MHz		17	26	pF
C _{rss}	Reverse Transfer Capacitance		-	7.8	12	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V _G =V _D =0V , Force Current			0.3	Α
I _{SM}	Pulsed Source Current	VG-VD-UV, FOICE Cullent			1.2	Α
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =1A , T _J =25℃			1	٧
t _{rr}	Reverse Recovery Time	V _{GS} =50V, I _S =1A , dI/dt=100A/μs		3.4		ns
Qrr	Reverse Recovery Charge	T _J =25℃		0.7		nC

- Repetitive Rating : Pulsed width limited by maximum junction temperature.
- The data tested by pulsed , pulse width $\leq 300 \text{us}$, duty cycle $\leq 2\%$.
- Essentially independent of operating temperature.



Continuous Drain Current vs. Tc

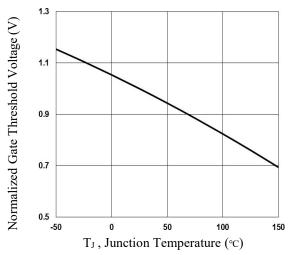


Fig.3 Normalized V_{th} vs. T_J

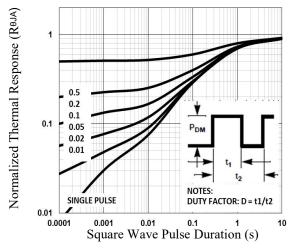


Fig.5 Normalized Transient Impedance

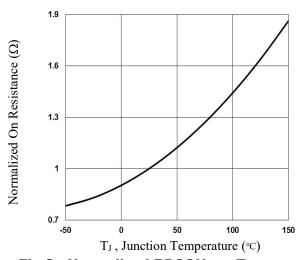
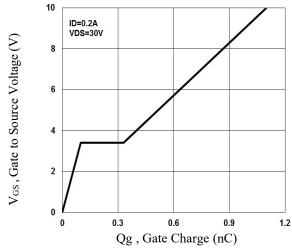


Fig.2 Normalized RDSON vs. T_J



Gate Charge Waveform

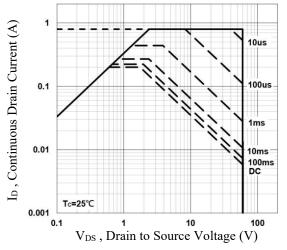
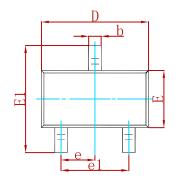


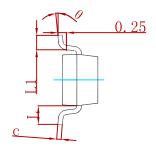
Fig.6 Maximum Safe Operation Area

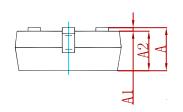




PACKAGE MECHANICAL DATA

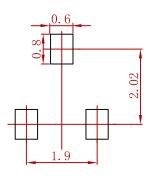






Symbol	Dimensions	Dimensions In Millimeters		s In Inches
Зупівої	Min	Max	Min	Max
Α	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
С	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
е	0.950) TYP	0.037	7 TYP
e1	1.800	2.000	0.071	0.079
Ĺ	0.550 REF 0.022 RE		2 REF	
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

Suggested Pad Layout



- 1.Controlling dimension:in millimeters.2.General tolerance:± 0.05mm.3.The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
2N7002-7-MS	SOT-23	3000



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